

Section 28

MOS Electrostatics & MOScap

28.5 MOScap Exact solution of the electrostatic problem

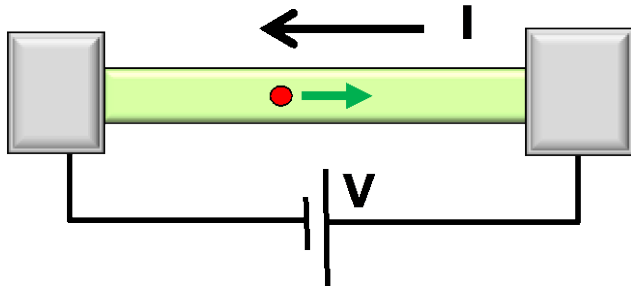
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School of Electrical and
Computer Engineering

Section 28

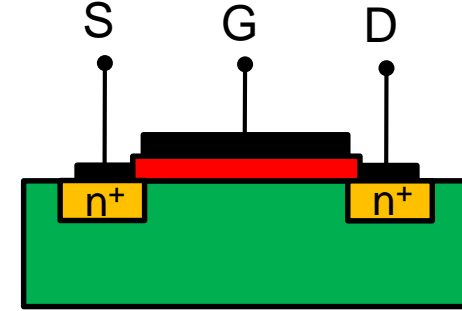
MOS Electrostatics & MOScap



$$I = G \times V$$

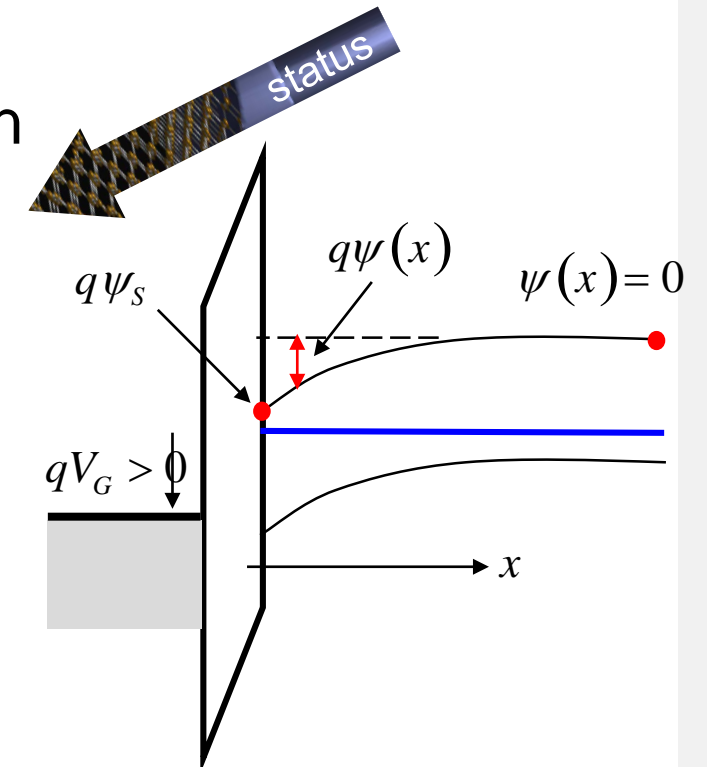
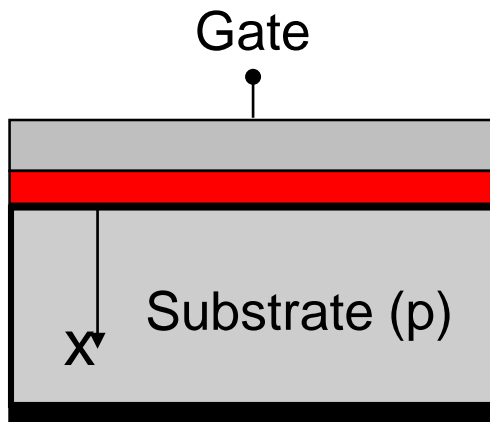
$$= q \times n \times v \times A$$

↑ charge density
 ↑ density
 ↑ velocity
 area

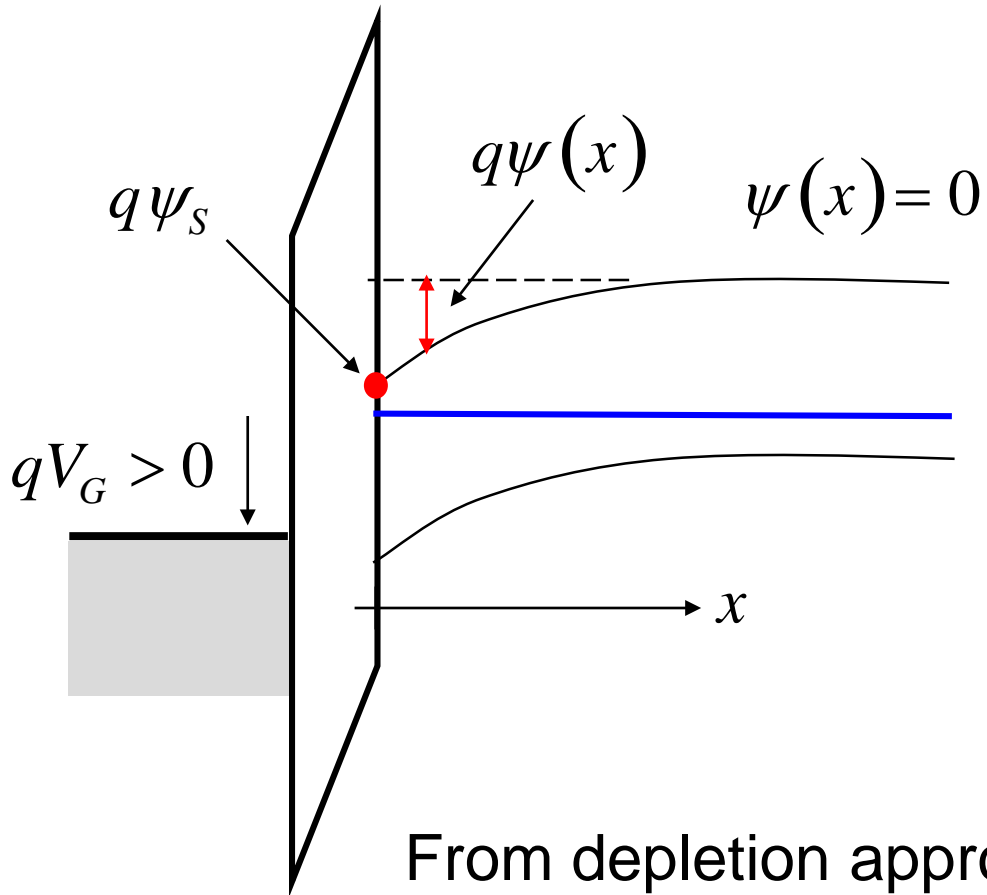


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- 28.1 Background
- 28.2 Band diagram in equilibrium and with bias => MOScap
- 28.3 Qualitative Q-V characteristics of MOS capacitor
- 28.4 MOScap Induced charges in depletion and inversion
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A step back: 'Exact' Solution of $Q_s(\psi_s)$



$$\nabla \cdot \vec{D} = \rho$$

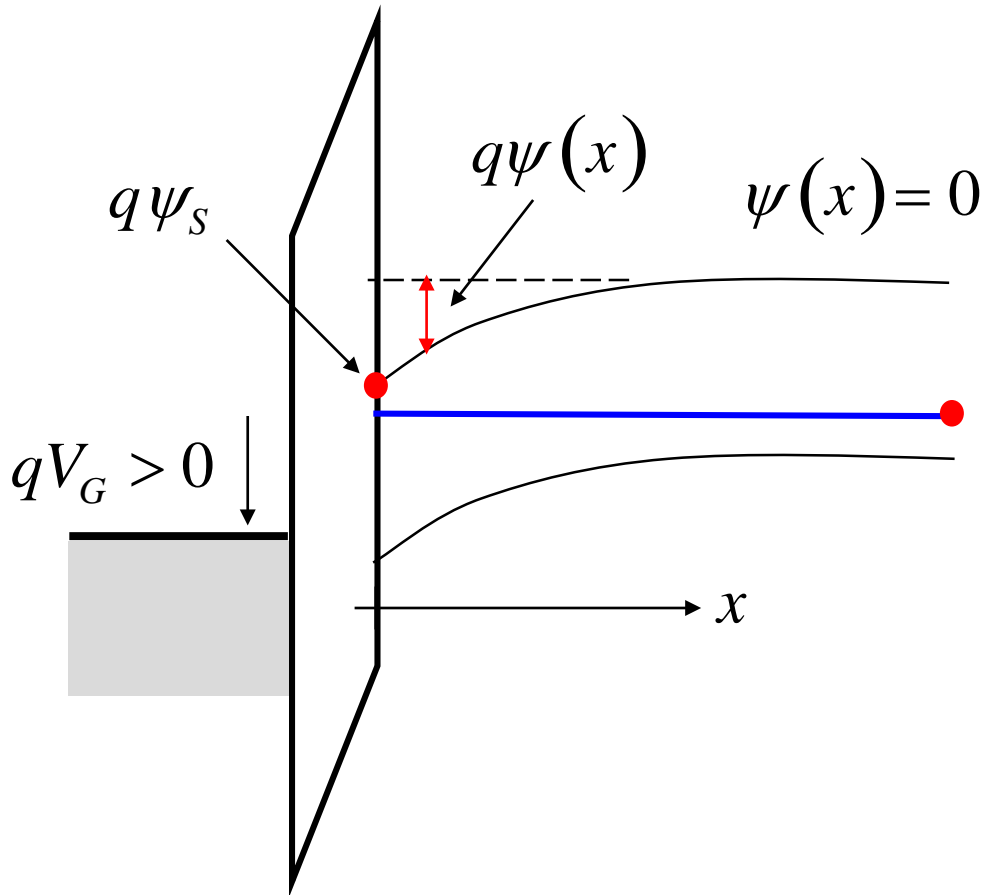
$$\nabla \cdot \left(\frac{J_n}{-q} \right) = (G - R)$$

$$\nabla \cdot \left(\frac{J_p}{q} \right) = (G - R)$$

$$\left. \frac{d^2\psi}{dx^2} \right| = \frac{-q}{\kappa_s \epsilon_0} \left[p(x) - n(x) + N_D^+ - N_A^- \right]$$

From depletion approximation ... $V_G = \frac{qN_A x_0}{\kappa_{ox} \epsilon_0} \sqrt{\frac{2\kappa_{ox} \epsilon_0}{qN_A}} \sqrt{\psi_s} + \psi_s$

Normalized Variable (to save some writing)...



$$\frac{d^2\psi}{dx^2} = \frac{-q}{\kappa_s \epsilon_0} [p(x) - n(x) + N_D^+ - N_A^-]$$

$$E_C(x) = \text{constant} - q\psi(x)$$

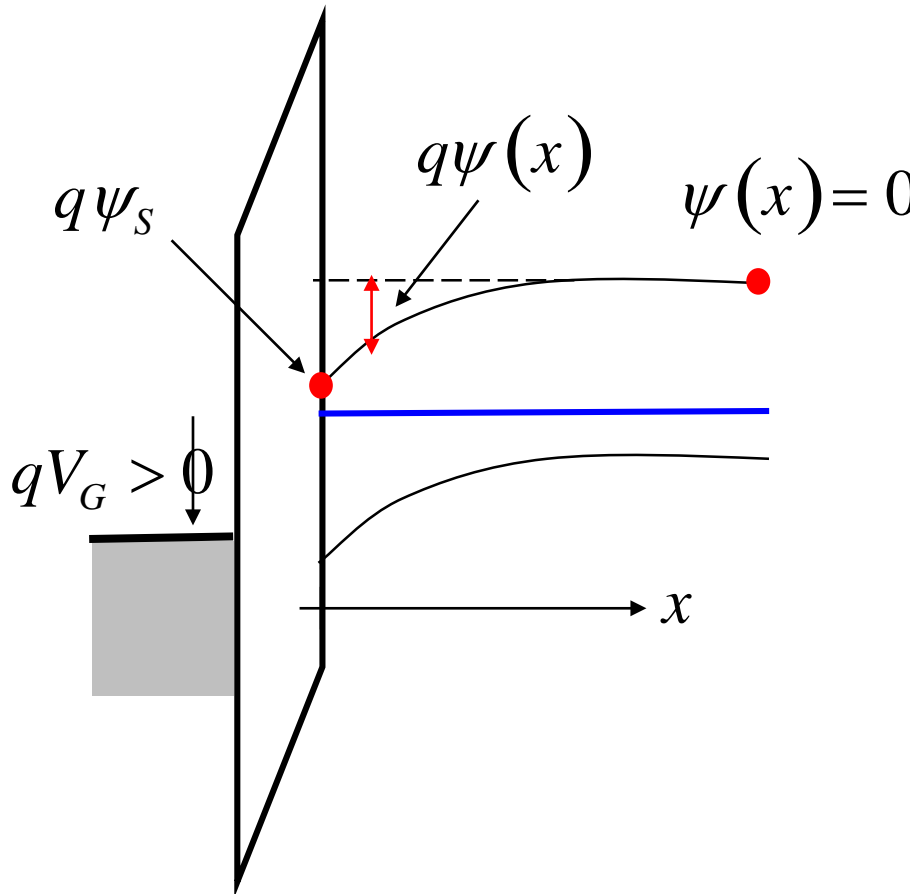
$$\psi(x) = \frac{E_{C,bulk} - E_C(x)}{q}$$

$$u = \frac{\psi(x)}{k_B T / q} = \frac{E_{i(bulk)} - E_{i(x)}}{k_B T}$$

$$u_s = \frac{\psi_s}{k_B T / q} = \frac{E_{i(bulk)} - E_{i(surface)}}{k_B T}$$

$$u_F = \frac{\phi_F}{k_B T / q} = \frac{E_{i(bulk)} - E_F}{k_B T}$$

Normalized Variable (to save some writing!)



$$\frac{d^2\psi}{dx^2} = \frac{-q}{\kappa_s \epsilon_0} [p(x) - n(x) + N_D^+ - N_A^-]$$

$$u = \frac{\psi(x)}{k_B T / q} = \frac{E_{i(bulk)} - E_{i(x)}}{k_B T} \quad u_F = \frac{\phi_F}{k_B T / q} = \frac{E_{i(bulk)} - E_F}{k_B T}$$

$$p(x) = n_i e^{[E_i(x) - E_F] \beta} = n_i e^{+(U_F - U)}$$

$$n(x) = n_i e^{-[E_i(x) - E_F] \beta} = n_i e^{-(U_F - U)}$$

$$N_D^+ = n_i e^{[E_F - E_{i,bulk}] \beta} = n_i e^{-(U_F)}$$

$$N_A^- = n_i e^{-[E_F - E_{i,bulk}] \beta} = n_i e^{(U_F)}$$

Assuming either donor or acceptor is present

Poisson-Boltzmann Equation

$$\frac{d^2\psi}{dx^2} = \frac{-q}{\kappa_s \epsilon_0} \left[p(x) - n(x) + N_D^+ - N_A^- \right]$$

$$n(x) = n_i e^{-[E_i(x) - E_F] \beta} = n_i e^{-(U_F - U)} \quad N_D^+ = n_i e^{[E_F - E_{i,bulk}] \beta} = n_i e^{-(U_F)}$$

$$p(x) = n_i e^{[E_i(x) - E_F] \beta} = n_i e^{+(U_F - U)} \quad N_A^- = n_i e^{-[E_F - E_{i,bulk}] \beta} = n_i e^{(U_F)}$$

$$\frac{q}{k_B T} \frac{d^2 U}{dx^2} = \frac{-q n_i}{\kappa_s \epsilon_0} \left[e^{+(U_F - U)} - e^{-(U_F - U)} + n_i e^{-U_F} - n_i e^{U_F} \right] \equiv g(U, U_F)$$

Can be evaluated at any U

$$\frac{d}{dx} \left(\frac{dU}{dx} \right)^2 = 2 \left(\frac{dU}{dx} \right)^1 \times \frac{d}{dx} \frac{dU}{dx} = 2 \frac{dU}{dx} \frac{d^2 U}{dx^2}$$

$$\left(2 \frac{dU}{dx} \right) \times \frac{d^2 U}{dx^2} = - \left(\frac{n_i k_B T}{\kappa_s \epsilon_0} \right) g(U, U_F) \times \left(2 \frac{dU}{dx} \right)$$

$$\frac{d}{dx} \left(\frac{dU}{dx} \right)^2 dx = - \frac{1}{2L_D^2} g(U, U_F) \left(2 \frac{dU}{dx} \right) dx$$

Debye Length

$$\int_0^{-q\mathcal{E}(x)/kT} d \left(\frac{dU}{dx} \right)^2 = - \frac{1}{L_D^2} \int_0^{U(x)} g(U, U_F) dU$$

Exact Solution (continued)

$$\int_0^{-q\mathcal{E}(x)/kT} d\left(\frac{dU}{dx}\right)^2 = -\frac{1}{L_D^2} \int_0^{U(x)} g(U, U_F) dU$$

$$\left[\frac{q\mathcal{E}(x)}{kT}\right]^2 = \frac{1}{L_D^2} \int_0^{U(x)} g(U, U_F) dU \equiv \frac{F^2(U, U_F)}{L_D^2}$$

Exact F requires numerical solution

At the surface

$$\mathcal{E}_s = \frac{k_B T}{q L_D} F(U_s, U_F)$$

Compare ...

$$V_G = \frac{q N_A x_0}{\kappa_{ox} \epsilon_0} \sqrt{\frac{2 \kappa_{ox} \epsilon_0}{q N_A}} \sqrt{\psi_s + \psi_s}$$

$$V_G = \psi_s + \left[\frac{\kappa_s}{\kappa_{ox}} \mathcal{E}_s \right] x_0 = \psi_s + \frac{\kappa_s}{\kappa_{ox}} \frac{k_B T}{q L_D} F(U_s, U_F) x_0$$

← V_{ox}

Recipe for numerical solution ...

$$\left[\frac{q\mathcal{E}(x)}{kT} \right]^2 = \frac{1}{L_D^2} \int_0^{U(x)} g(U, U_F) dU \equiv \frac{F^2(U, U_F)}{L_D^2}$$

$$V_G = \psi_s + \frac{\kappa_s}{\kappa_{ox}} \mathcal{E}_s x_0 = \psi_s + \frac{\kappa_s}{\kappa_{ox}} \frac{k_B T}{q L_D} F(U_s, U_F) x_0$$

Begin with a surface potential

Calculate U_s and then divide U_s by N points.

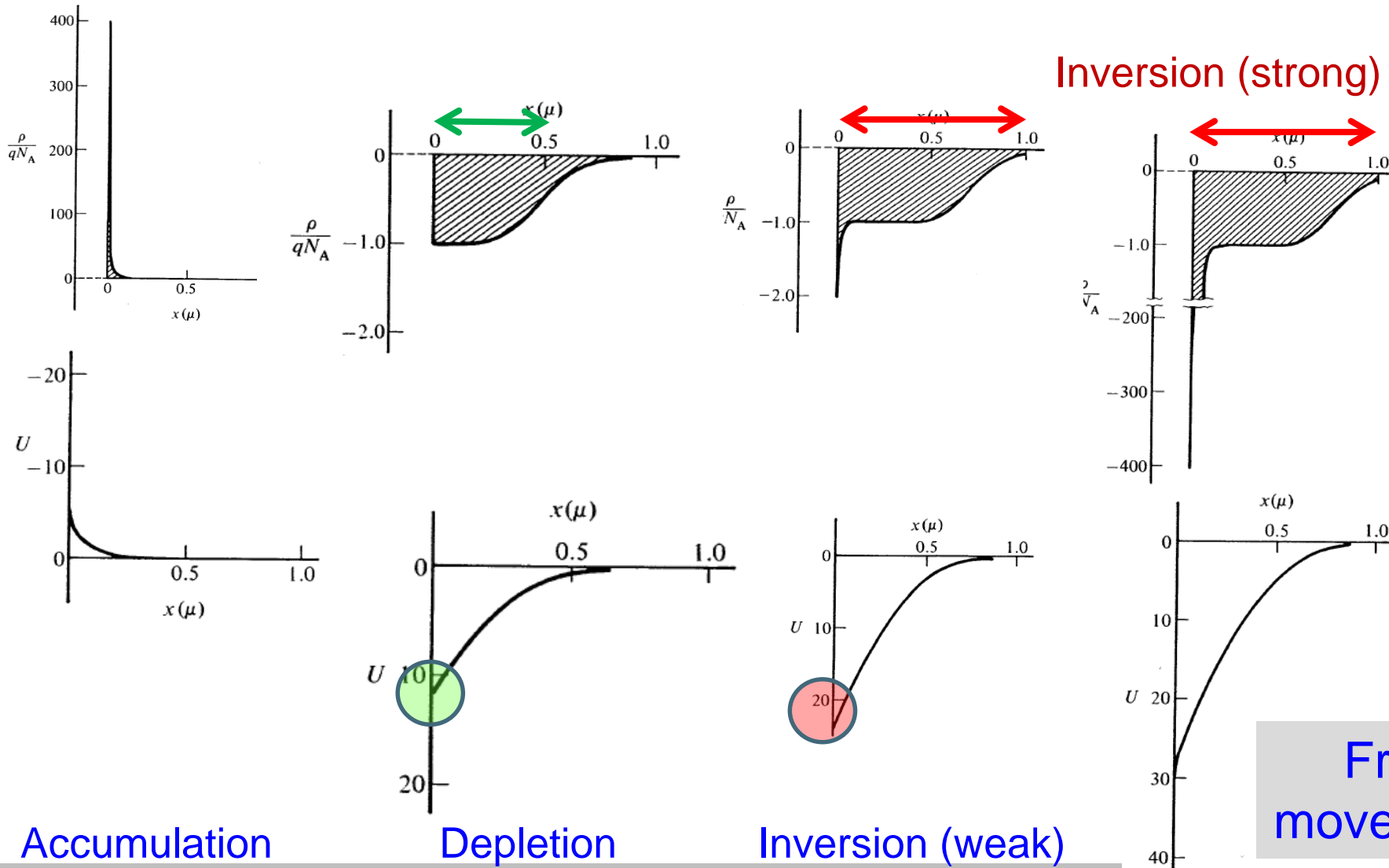
Calculate $g(U, U_F)$ at those points
and integrate to find $F(U_s, U_F)$

Find V_G .

Exact Solution...

U: 25 → 30

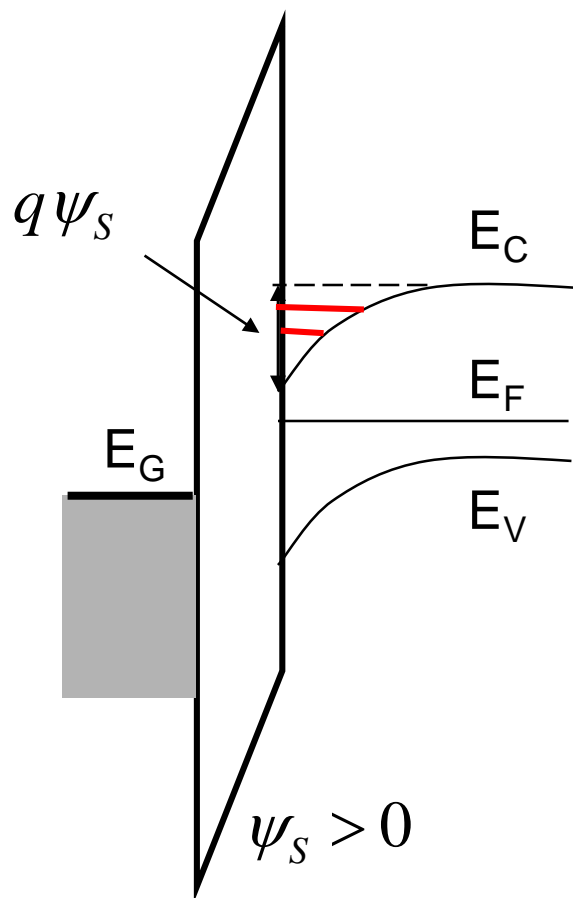
Charge density: -2.0 → -400



Free charge moves to interface

Huge spike! Hard to resolve numerically! Realistic?

"Exact" solution is not really exact ...



$$\frac{d^2\psi}{dx^2} = \frac{-q}{\epsilon} \left[p(x) - n(x) |\psi(x)|^2 + N_D^+ - N_A^- \right]$$

↓
wavefunction, not potential !

Wave function should be accounted for

Bandgap widening near the interface must also be accounted for.

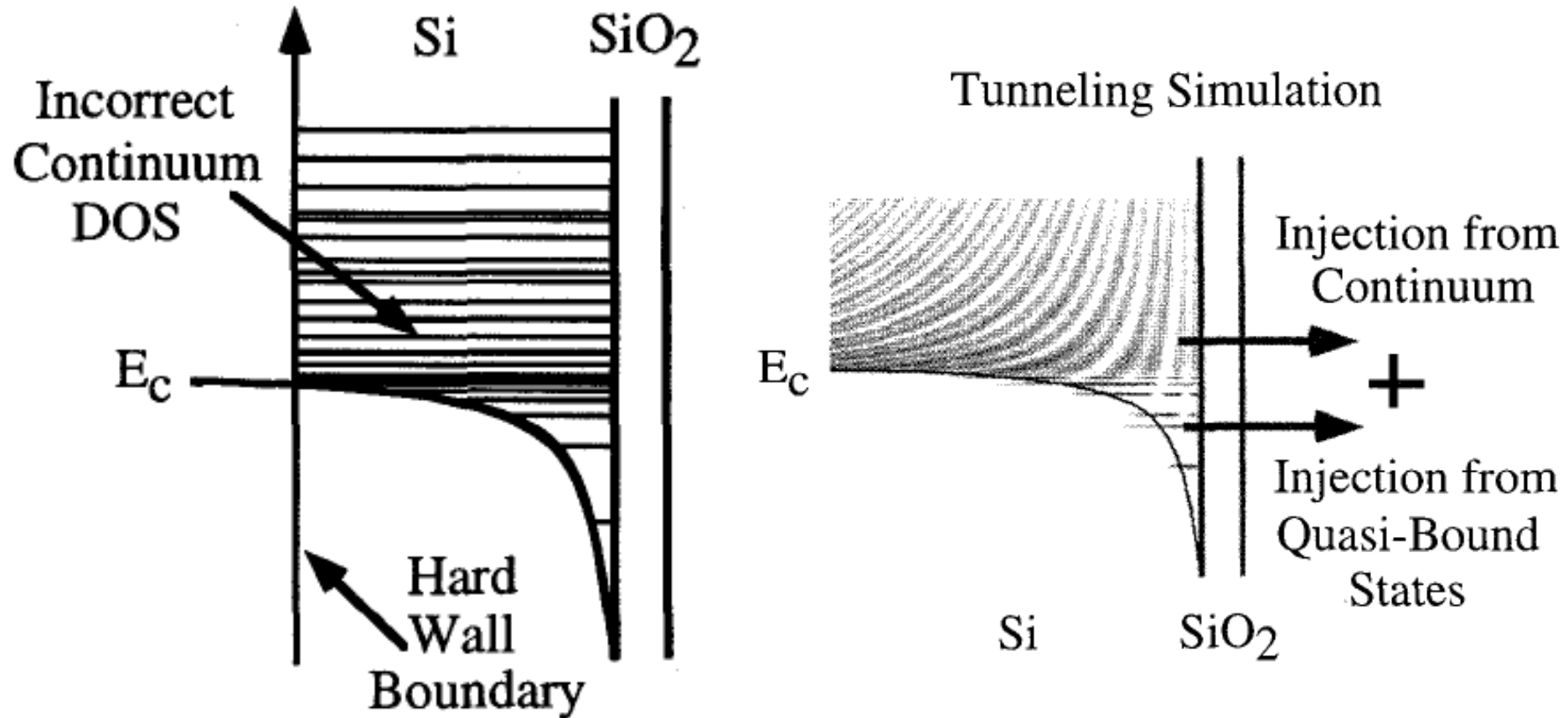
Assumption of nondegeneracy may not always be valid

"Exact" solution is not really exact ... really

R. Bowen, Chenjing Fernando, Gerhard Klimeck, Amitava Chatterjee, Daniel Blanks, Roger Lake, J. Hu, Joseph Davis, M. Kularni, Sunil Hattangady, I.C. Chen,

"Physical Oxide Extraction and Versification using Quantum Mechanical Simulation"

Proceedings of IEDM 1997, IEEE, 869 (1997); [doi : 10.1109/IEDM.1997.650518](https://doi.org/10.1109/IEDM.1997.650518), [Cited by 42](#)

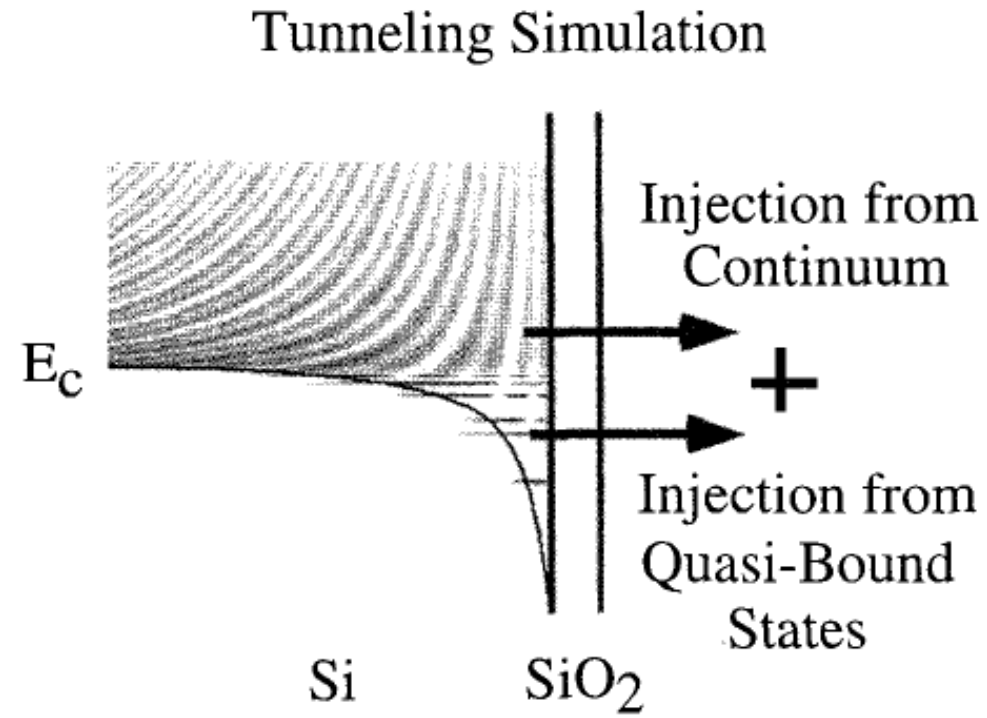
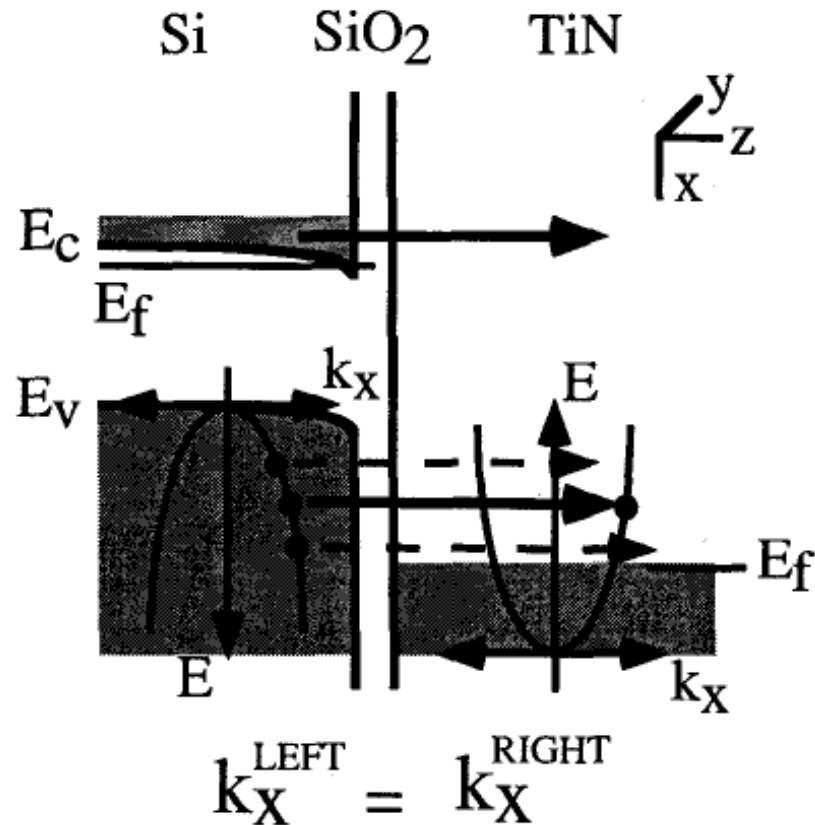


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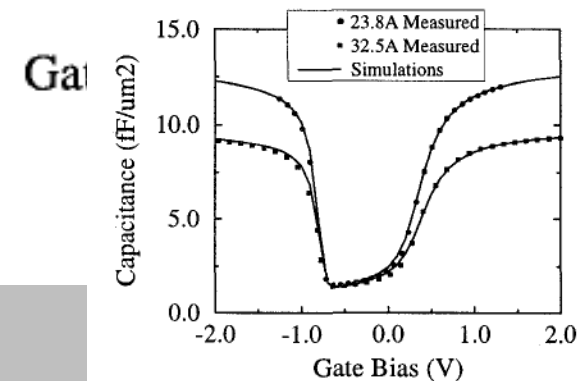
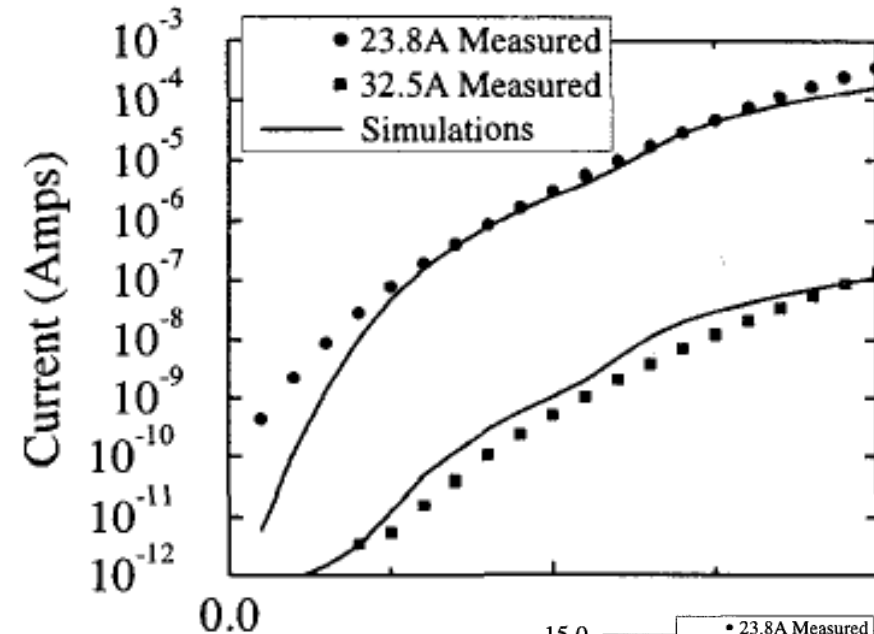
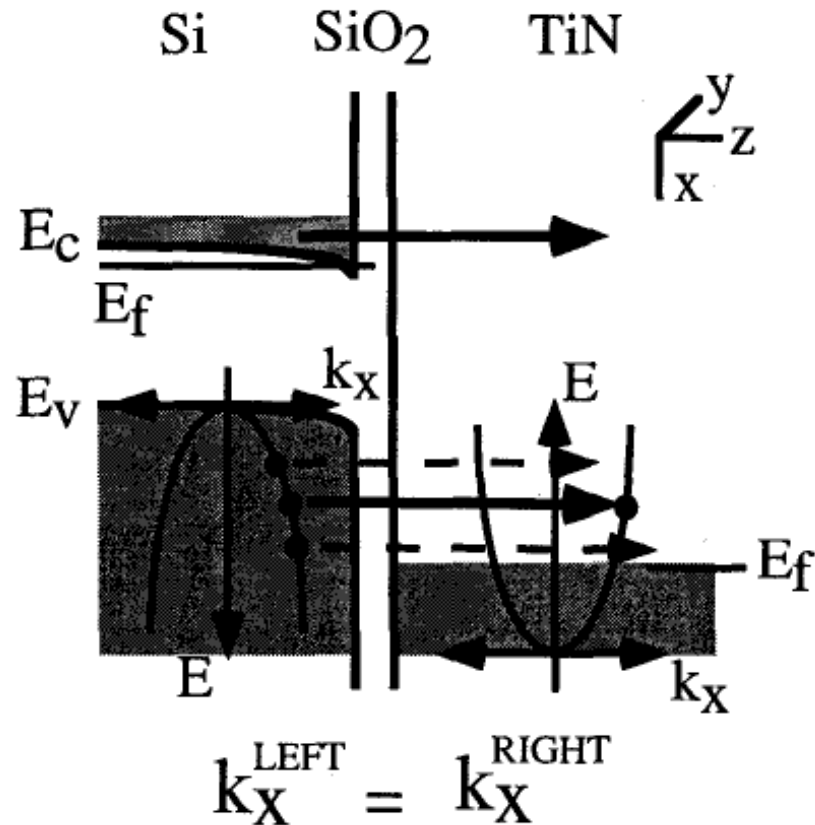


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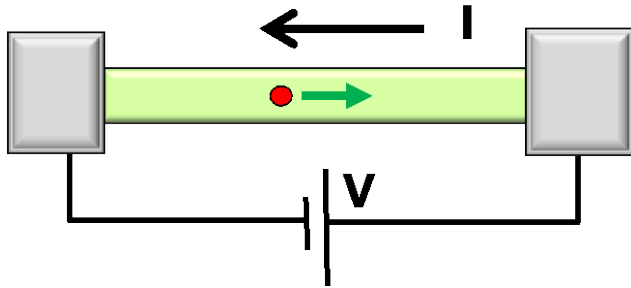
Conclusion

Our discussion today was focused on calculating the induced charge in the depletion and inversion region as a function of gate bias.

We found that we could calculate the tunneling current from the inversion changes by using the thermionic emission theory.

We also discussed the “exact” solution of the MOS-capacitor electrostatics. The “exact” solution is mathematically exact, but not necessarily physically exact solution of the electrostatic problem.

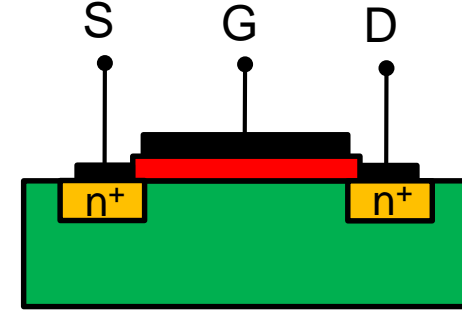
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